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**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

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PN*

In Re:	Frank Olschewski	Confirmation No:	5943
Serial No:	09/683,795	Group:	2673
Filed:	February 15, 2002	Examiner:	Nguyen, Phu K.
For:	Method and Arrangement for Imaging and Measuring Microscopic Three-Dimensional Structures		
Customer No.:	29127		
Attorney Docket No.	21295.41		

**AFTER FINAL AMENDMENT UNDER RULE 116**

VIA FACSIMILE: 571-273-8300  
Mail Stop AF  
Commissioner for Patents  
P.O. Box 1450  
Alexandria, Virginia 22313-1450

Sir:

In response to the pending final Office Action, mailed June 15, 2005 (Paper No. 061005), please amend the above-captioned patent application as follows:

-amendments to the claims are reflected in the listing of claims in section a);

Finally, reconsideration is requested in view of the remarks set forth in section b).

11/16/2005 EFLDRES 00000085 502233 09683795

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